

## General Description

The AAT8343 is a low threshold MOSFET designed for the battery, cell phone, and PDA markets. Using AnalogicTech™'s ultra high density proprietary TrenchDMOS™ technology, this product demonstrates high power handling and small size.

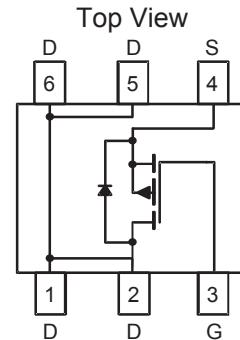
## Features

- $V_{DS(MAX)} = -20V$
- $I_{D(MAX)}^1 = -4.5A @ 25^\circ C$
- Low  $R_{DS(ON)}$ :
  - $60\ m\Omega @ V_{GS} = -4.5V$
  - $110\ m\Omega @ V_{GS} = -2.5V$

## Applications

- Battery Packs
- Cellular & Cordless Telephones
- Battery-powered portable equipment

## TSOP-6 Package



## Absolute Maximum Ratings ( $T_A=25^\circ C$ unless otherwise noted)

Symbol	Description	Value	Units
$V_{DS}$	Drain-Source Voltage	-20	V
$V_{GS}$	Gate-Source Voltage	$\pm 12$	
$I_D$	Continuous Drain Current @ $T_J=150^\circ C$ <sup>1</sup>	$T_A = 25^\circ C$	A
		$T_A = 70^\circ C$	
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	$\pm 16$	A
$I_S$	Continuous Source Current (Source-Drain Diode) <sup>1</sup>	-1.3	
$P_D$	Maximum Power Dissipation <sup>1</sup>	$T_A = 25^\circ C$	W
		$T_A = 70^\circ C$	
$T_J, T_{STG}$	Operating Junction and Storage Temperature Range	-55 to 150	°C

## Thermal Characteristics

Symbol	Description	Typ	Max	Units
$R_{\theta JA}$	Junction-to-Ambient steady state <sup>1</sup>	95	115	°C/W
$R_{\theta JA2}$	Junction-to-Ambient t<5 seconds <sup>1</sup>	51	62	°C/W
$R_{\theta JF}$	Junction-to-Foot <sup>1</sup>	25	30	°C/W

## Electrical Characteristics ( $T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Description	Conditions	Min	Typ	Max	Units
<b>DC Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=-250\mu\text{A}$	-20			V
$R_{\text{DS}(\text{ON})}$	Drain-Source ON-Resistance <sup>2</sup>	$V_{\text{GS}}=-4.5\text{V}, I_{\text{D}}=-4.5\text{A}$		49	60	$\text{m}\Omega$
		$V_{\text{GS}}=-2.5\text{V}, I_{\text{D}}=-3.3\text{A}$		85	110	
$I_{\text{D}(\text{ON})}$	On-State Drain Current <sup>2</sup>	$V_{\text{GS}}=-4.5\text{V}, V_{\text{DS}}=-5\text{V}$ (Pulsed)	-16			A
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=-250\mu\text{A}$	-0.6			V
$I_{\text{GSS}}$	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 12\text{V}, V_{\text{DS}}=0\text{V}$			$\pm 100$	nA
$I_{\text{DSS}}$	Drain Source Leakage Current	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=-20\text{V}$			-1	$\mu\text{A}$
		$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=-16\text{V}, T_J=70^\circ\text{C}$ <sup>3</sup>			-5	
$g_{\text{fs}}$	Forward Transconductance <sup>2</sup>	$V_{\text{DS}}=-5\text{V}, I_{\text{D}}=-4.5\text{A}$		7		S
<b>Dynamic Characteristics</b> <sup>3</sup>						
$Q_G$	Total Gate Charge	$V_{\text{DS}}=-10\text{V}, R_D=2.2\Omega, V_{\text{GS}}=-4.5\text{V}$		8.5		nC
$Q_{\text{GS}}$	Gate-Source Charge	$V_{\text{DS}}=-10\text{V}, R_D=2.2\Omega, V_{\text{GS}}=-4.5\text{V}$		1.8		
$Q_{\text{GD}}$	Gate-Drain Charge	$V_{\text{DS}}=-10\text{V}, R_D=2.2\Omega, V_{\text{GS}}=-4.5\text{V}$		2.9		
$t_{\text{D}(\text{ON})}$	Turn-ON Delay	$V_{\text{DS}}=-10\text{V}, R_D=2.2\Omega, V_{\text{GS}}=-4.5\text{V}, R_G=6\Omega$		12		ns
$t_R$	Turn-ON Rise Time	$V_{\text{DS}}=-10\text{V}, R_D=2.2\Omega, V_{\text{GS}}=-4.5\text{V}, R_G=6\Omega$		32		
$t_{\text{D}(\text{OFF})}$	Turn-OFF Delay	$V_{\text{DS}}=-10\text{V}, R_D=2.2\Omega, V_{\text{GS}}=-4.5\text{V}, R_G=6\Omega$		64		
$t_F$	Turn-OFF Fall Time	$V_{\text{DS}}=-10\text{V}, R_D=2.2\Omega, V_{\text{GS}}=-4.5\text{V}, R_G=6\Omega$		40		
<b>Source-Drain Diode Characteristics</b>						
$V_{\text{SD}}$	Source-Drain Forward Voltage <sup>2</sup>	$V_{\text{GS}}=0, I_S=-4.5\text{A}$			-1.3	V
$I_S$	Continuous Diode Current <sup>1</sup>				-1.3	A

Note 1: Based on thermal dissipation from junction to ambient while mounted on a 1" x 1" PCB with optimized layout. A 5 second pulse on a 1" x 1" PCB approximates testing a device mounted on a large multi-layer PCB as in most applications.  $R_{\theta,\text{JF}} + R_{\theta,\text{FA}} = R_{\theta,\text{JA}}$  where the foot thermal reference is defined as the normal solder mounting surface of the device's leads.  $R_{\theta,\text{JF}}$  is guaranteed by design, however  $R_{\theta,\text{CA}}$  is determined by the PCB design. Actual maximum continuous current is limited by the application's design.

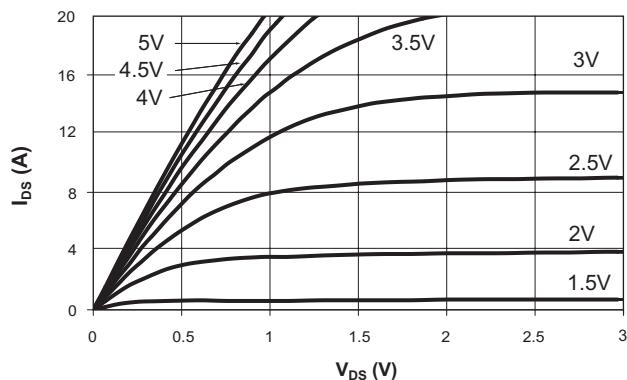
Note 2: Pulse test: Pulse Width = 300  $\mu\text{s}$

Note 3: Guaranteed by design. Not subject to production testing.

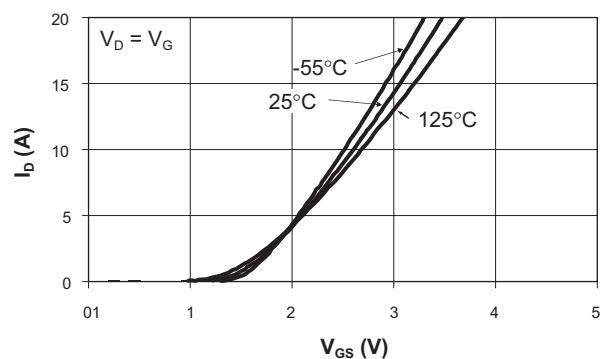
## Typical Characteristics

( $T_J = 25^\circ\text{C}$  unless otherwise noted)

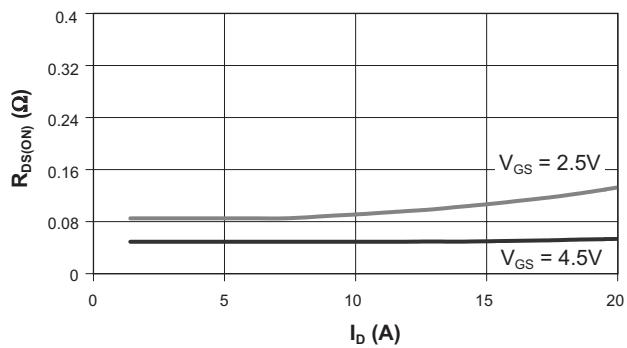
**Output Characteristics**



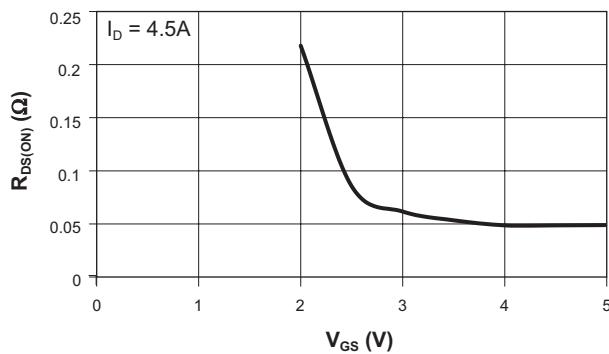
**Transfer Characteristics**



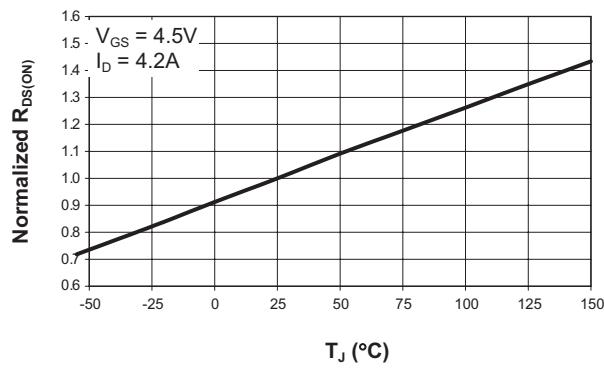
**On-Resistance vs. Drain Current**



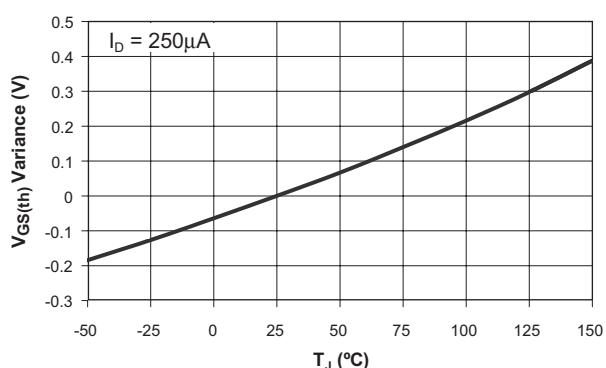
**On-Resistance vs. Gate to Source Voltage**



**On-Resistance vs. Junction Temperature**



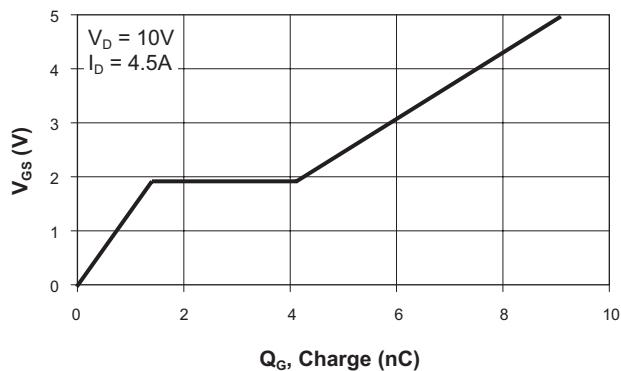
**Threshold Voltage**



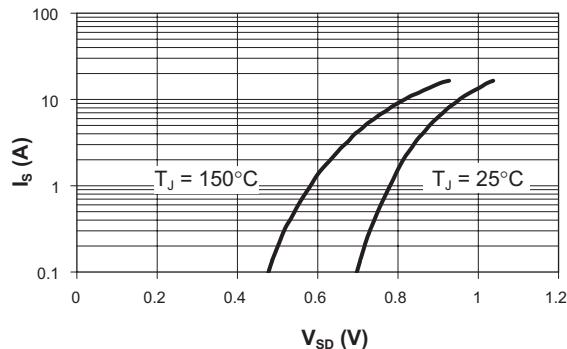
## Typical Characteristics

( $T_J = 25^\circ\text{C}$  unless otherwise noted)

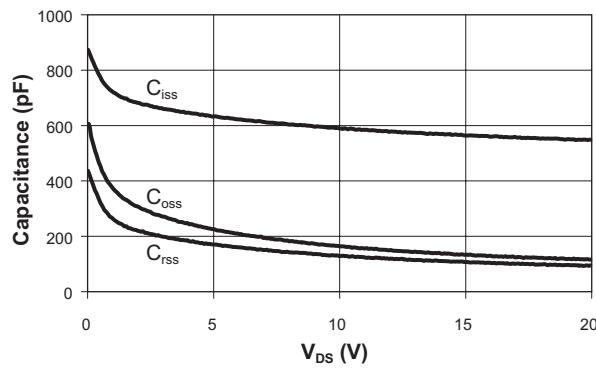
**Gate Charge**



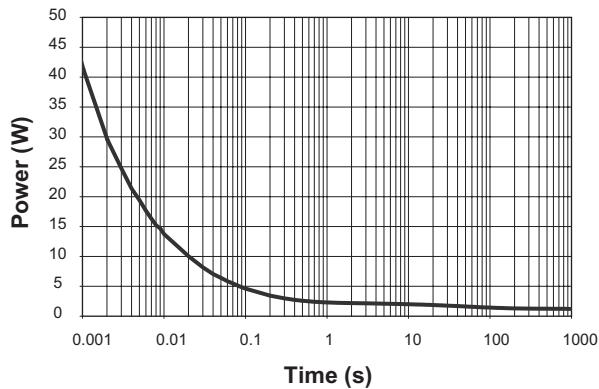
**Source-Drain Diode Forward Voltage**



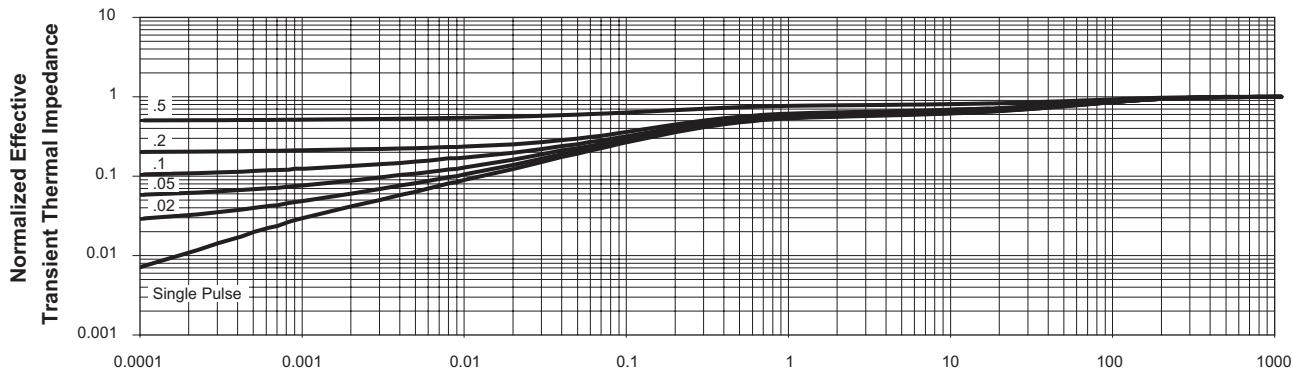
**Capacitance**



**Single Pulse Power, Junction to Ambient**



**Transient Thermal Response, Junction to Ambient**

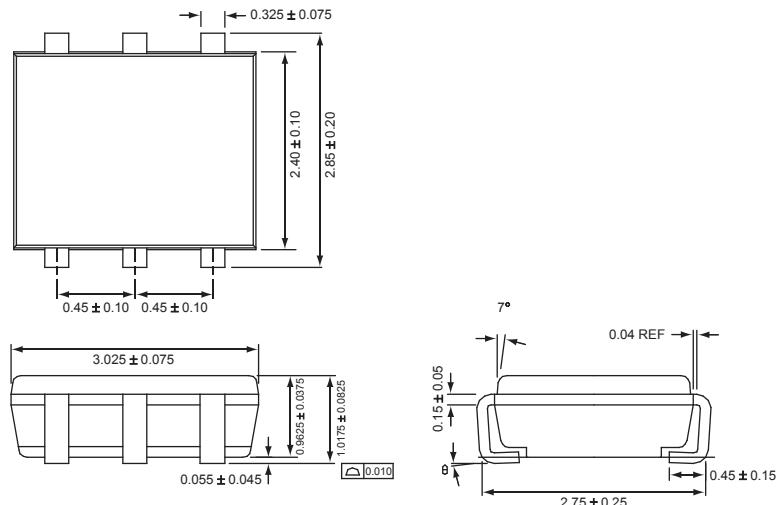


## Ordering Information

Package	Marking <sup>1</sup>	Part Number (Tape and Reel)
TSOP-6	KEXYY	AAT8343IDU-T1

Note 1: XYY = assembly and date code.

## Package Information



All dimensions in millimeters.

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